

FDR8308P

Dual P-Channel, Logic Level, PowerTrench™ MOSFET

General Description

The SuperSOT-8 family of P-Channel Logic Level MOSFETs have been designed to provide a low profile, small footprint alternative to industry standard SO-8 little foot type product.

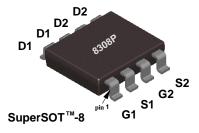
These P-Channel Logic Level MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been tailored to minimize the on-state resistance and yet maintain superior switching performance.

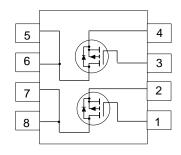
These devices are well suited for portable electronics applications: load switching and power management, battery charging circuits, and DC/DC conversion.

Features

- -3.2 A, -20 V. $R_{DS(ON)} = 0.050~\Omega~@~V_{GS} = -4.5~V,$ $R_{DS(ON)} = 0.070~\Omega~@~V_{GS} = -2.5~V.$
- Low gate charge (13nC typical).
- High performance trench technology for extremely low R_{DS/OND}.
- SuperSOT[™]-8 package: small footprint (40% less than SO-8); low profile(1mmthick); maximum power comparable to SO-8.







Absolute Maximum Ratings $T_A = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	FDR8308P	Units	
DSS	Drain-Source Voltage	-20	V	
GSS	Gate-Source Voltage	±8	V	
	Draint Current - Continuous (Note 1)	-3.2	A	
	- Pulsed	-20		
D	Maximum Power Dissipation (Note 1)	0.8	W	
J,T _{STG}	Operating and Storage Temperature Range	-55 to 150	℃	
HERMA	CHARACTERISTICS		•	
θJA	Thermal Resistance, Junction-to-Ambient (Note 1)	156	°C/W	
, BUC	Thermal Resistance, Junction-to-Case (Note 1)	40	°C/W	

Symbol	Parameter Conditions				Тур	Max	Units
OFF CHAR	ACTERISTICS						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$		-20			V
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient	$I_D = -50 \mu\text{A}$, Referenced to 25	°C		-16		mV /°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -16 \text{ V}, \ V_{GS} = 0 \text{ V}$				-1	μA
		T _J	= 55°C			-10	μA
I _{GSS}	Gate - Body Leakage Current	$V_{GS} = 8 \text{ V}, \ V_{DS} = 0 \text{ V}$				100	nA
I _{GSS}	Gate - Body Leakage, Reverse	$V_{GS} = -8 \text{ V}, \ V_{DS} = 0 \text{ V}$				-100	nA
	CTERISTICS (Note 2)		,			•	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$		-0.4	-0.9	-1.5	V
$\Delta V_{GS(th)}/\Delta T_{J}$	Gate Threshold Voltage Temp.Coefficient	$I_D = -50 \mu\text{A}$, Referenced to 25	°C		2.5		mV /°C
R _{DS(ON)}	Static Drain-Source On-Resistance	$V_{GS} = -4.5 \text{ V}, I_{D} = -3.2 \text{ A}$			0.038	0.05	Ω
(,		T _J =	= 125°C		0.053	0.075	
		$V_{GS} = -2.5 \text{ V}, I_{D} = -2.7 \text{ A}$			0.054	0.07	
I _{D(ON)}	On-State Drain Current	$V_{GS} = -4.5 \text{ V}, \ V_{DS} = -5 \text{ V}$		-20			Α
g _{FS}	Forward Transconductance	$V_{DS} = -4.5 \text{ V}, I_{D} = -3.2 \text{ A}$			13		S
DYNAMIC C	HARACTERISTICS	<u> </u>				•	
C _{iss}	Input Capacitance	$V_{DS} = -10 \text{ V}, \ V_{GS} = 0 \text{ V},$			1240		pF
C _{oss}	Output Capacitance	f = 1.0 MHz			270		pF
C _{rss}	Reverse Transfer Capacitance		-		100		pF
SWITCHING	CHARACTERISTICS (Note 2)						
$t_{D(on)}$	Turn - On Delay Time	$V_{DD} = -5 \text{ V}, I_{D} = -1 \text{ A},$			8	16	ns
t,	Turn - On Rise Time	$V_{GS} = -4.5 \text{ V}, R_{GEN} = 6 \Omega$			15	27	ns
$t_{D(off)}$	Turn - Off Delay Time		-		45	65	ns
t _r	Turn - Off Fall Time		-		30	50	ns
Q_g	Total Gate Charge	$V_{DS} = -10 \text{ V}, I_{D} = -4.5 \text{ A},$			13	19	nC
Q_{gs}	Gate-Source Charge	$V_{GS} = -4.5 \text{ V}$			1.8		nC
Q_{gd}	Gate-Drain Charge				3		nC
DRAIN-SO	JRCE DIODE CHARACTERISTICS AND N	IAXIMUM RATINGS					
I _s	Maximum Continuous Drain-Source Diode F				-0.67	Α	
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = -0.67 \text{ A} \text{ (Note 2)}$			-0.7	-1.2	V

Notes:

^{1.} $R_{g,lA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{g,lC}$ is guaranteed by design while $R_{g,CA}$ is determined by the user's board design.



156°C/W on a 0.0025 in² pad of 2oz copper.



Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2.0%.

Typical Electrical Characteristics

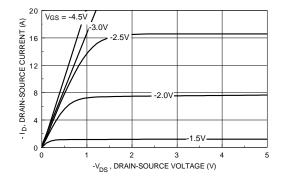


Figure 1. On-Region Characteristics.

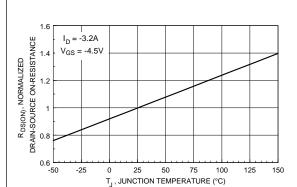


Figure 3. On-Resistance Variation with Temperature.

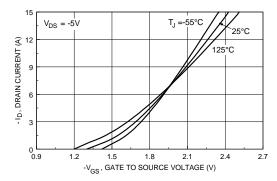


Figure 5. Transfer Characteristics.

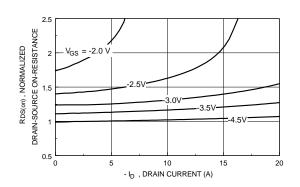


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

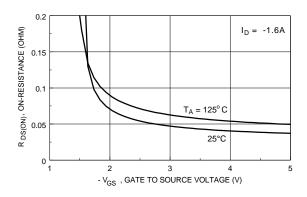


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

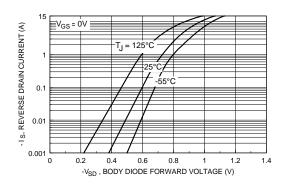
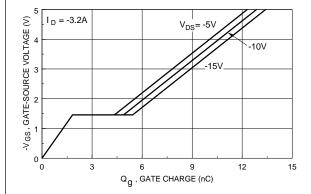


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Electrical Characteristics (continued)



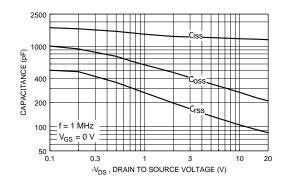
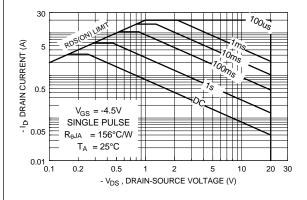


Figure 7. Gate Charge Characteristics.





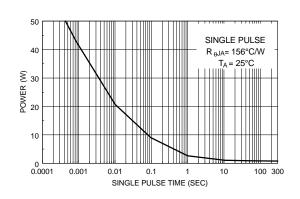


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

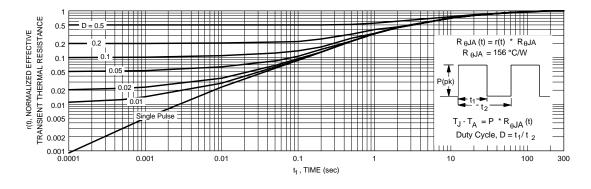
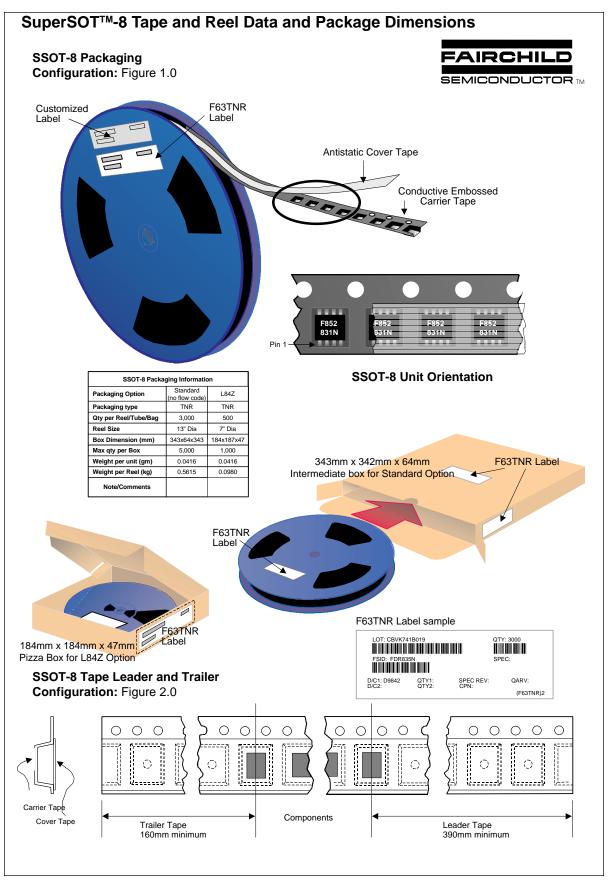


Figure 11. Transient Thermal Response Curve.

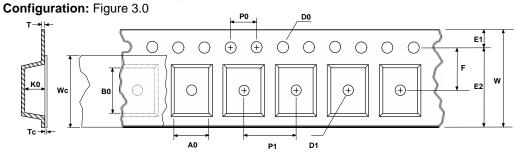
Thermal characterization performed using the conditions described in note 1.

Transient thermal response will change depending on the circuit board design.





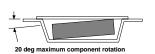
SSOT-8 Embossed Carrier Tape



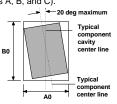
User Direction of Feed

Dimensions are in millimeter														
Pkg type	Α0	В0	w	D0	D1	E1	E2	F	P1	P0	K0	Т	Wc	Тс
SSOT-8 (12mm)	4.47 +/-0.10	5.00 +/-0.10	12.0 +/-0.3	1.55 +/-0.05	1.50 +/-0.10	1.75 +/-0.10	10.25 min	5.50 +/-0.05	8.0 +/-0.1	4.0 +/-0.1	1.37 +/-0.10	0.280 +/-0.150	9.5 +/-0.025	0.06 +/-0.02

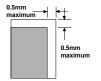
Notes: A0, B0, and K0 dimensions are determined with respect to the EIA/Jedec RS-481 rotational and lateral movement requirements (see sketches A, B, and C).



Sketch A (Side or Front Sectional View)
Component Rotation

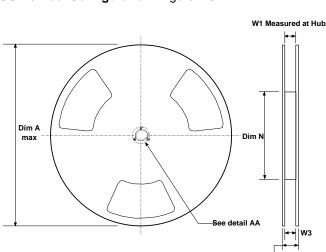


Sketch B (Top View)
Component Rotation

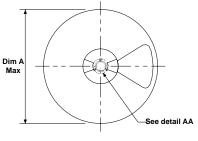


Sketch C (Top View)
Component lateral movement

SSOT-8 Reel Configuration: Figure 4.0



13" Diameter Option



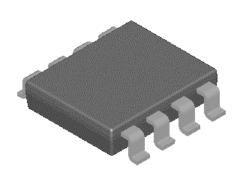
7" Diameter Option B Min Dim D min

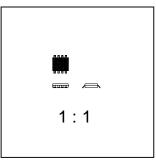
Dimensions are in inches and millimeters									
Tape Size	Reel Option	Dim A	Dim B	Dim C	Dim D	Dim N	Dim W1	Dim W2	Dim W3 (LSL-USL)
12mm	7" Dia	7.00 177.8	0.059 1.5	512 +0.020/-0.008 13 +0.5/-0.2	0.795 20.2	5.906 150	0.488 +0.078/-0.000 12.4 +2/0	0.724 18.4	0.469 - 0.606 11.9 - 15.4
12mm	13" Dia	13.00 330	0.059 1.5	512 +0.020/-0.008 13 +0.5/-0.2	0.795 20.2	7.00 178	0.488 +0.078/-0.000 12.4 +2/0	0.724 18.4	0.469 - 0.606 11.9 - 15.4

W2 max Measured at Hub

SuperSOT™-8 Tape and Reel Data and Package Dimensions, continued

SuperSOT™-8 (FS PKG Code 34, 35)

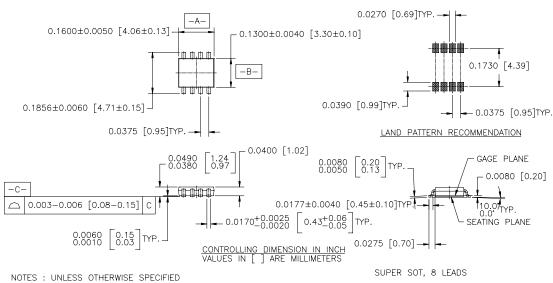




Scale 1:1 on letter size paper

Dimensions shown below are in: inches [millimeters]

Part Weight per unit (gram): 0.0416



STANDARD LEAD FINISH TI BE 200 MICROINCHES / 5.08 MICROMETERS MINIMUM TIN/LEAD (SOLDER) ON COPPER.

2. NO JEDEC REGISTRATION AS JAN. 1996

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FACTTM QSTM

FACT Quiet Series $^{\text{TM}}$ Quiet Series $^{\text{TM}}$ SuperSOT $^{\text{TM}}$ -3 SuperSOT $^{\text{TM}}$ -6 GTO $^{\text{TM}}$ SuperSOT $^{\text{TM}}$ -8 TinyLogic $^{\text{TM}}$

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